Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,252	HAN, CHANG HUN	
Examiner	Art Unit	
Richard A. Booth	2812	

		<u> </u>	
	SEAR	CHED	
Class	Subclass	Date	Examiner
438	257-267	2/28/2005	RAB
438	593-594	2/28/2005	RAB
ypda	ted.	0 10/up	- AMS

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)	
	DATE EXMR		
<u> </u>			
	1		
	 		